

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination SONEZAKI ET AL.	
		Examiner David M. Brunsman	Art Unit 1755	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0013976 A1	01-2004	Fujimoto et al.	430/270.14
*	B	US-2006/0003164 A1	01-2006	Pickett et al.	428/412
*	C	US-6,177,138	01-2001	Sawaragi et al.	427/387
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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